

## 30V N-Channel Enhancement Mode MOSFET

## Description

The SX180N03T uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

VDS=30V ID =180A

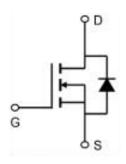
 $R_{DS(ON)} < 3.2 m\Omega$  @  $V_{GS}=10V$ 

## **Application**

Battery protection

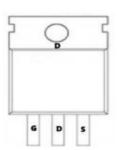
Load switch

Uninterruptible power supply









Absolute Maximum Ratings (Tc=25℃unless otherwise noted)

Symbol	Parameter	Rating	Units	
V <sub>D</sub> s	Drain-Source Voltage	30	V	
Vgs	Gate-Source Voltage	±20	V	
lo@Tc=25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1,6</sup>	180	Α	
lo@Tc=100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1,6</sup>	145	А	
Ідм	Pulsed Drain Current <sup>2</sup> 500		А	
EAS	Single Pulse Avalanche Energy <sup>3</sup> 246		mJ	
las	Avalanche Current	70.2	Α	
P <b>o@T</b> c= <b>25</b> °C	Total Power Dissipation <sup>4</sup> 187		W	
Тѕтс	Storage Temperature Range	-55 to 175	$^{\circ}$	
TJ	Operating Junction Temperature Range	-55 to 175	$^{\circ}$	
Reja	Thermal Resistance Junction-Ambient <sup>1</sup>	62	°C/W	
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	0.8	°C/W	





Electrical Characteristics (T」=25 ℃, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ip=250uA	30	38		V
△BVDSS/△TJ	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25℃, l <sub>D</sub> =1mA		0.014		V/°C
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	Vgs=10V , ID=30A		2.1	3.2	mΩ
		V <sub>G</sub> s=4.5V , I <sub>D</sub> =15A		3.0	3.8	
VGS(th)	Gate Threshold Voltage	\\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\	1.2	1.6	2.5	V
$\triangle V_{\text{GS(th)}}$	V <sub>GS(th)</sub> Temperature Coefficient	Vgs=Vps , Ip =250uA		-4		mV/℃
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃			1	uA
		V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	
IGSS	Gate-Source Leakage Current	Vgs=±20V , Vps=0V			±100	nA
gfs	Forward Transconductance	VDS=5V , ID=30A		50		S
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		1.7		Ω
$Q_g$	Total Gate Charge (4.5V)	V <sub>DS</sub> =15V , V <sub>GS</sub> =10V , I <sub>D</sub> =15A		56.9		nC
Qgs	Gate-Source Charge			13.8		
Qgd	Gate-Drain Charge			23.5		
Td(on)	Turn-On Delay Time			20.1		ns
Tr	Rise Time	VDD=15V , VGS=10V		6.3		
Td(off)	Turn-Off Delay Time	R <sub>G</sub> =3.3Ω, l <sub>D</sub> =1A		124.6		
Tf	Fall Time			15.8		
Ciss	Input Capacitance			5850		
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz		720		pF
Crss	Reverse Transfer Capacitance			525		
IS	Continuous Source Current <sup>1,5</sup>	\/\/\/\			205	Α
ISM	Pulsed Source Current <sup>2,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			500	Α
VSD	Diode Forward Voltage <sup>2</sup>	Vgs=0V , Is=1A , Tյ=25℃			1.2	V

#### Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2 . The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%
- 3 . The EAS data shows Max. rating . The test condition is VDD=25V,VGS=10V,L=0.1Mh,IAS=22A
- $4\,{\,{}^{^\circ}}$  The power dissipation is limited by  $175\,{\,}^\circ\!{\,}{}^\circ$  junction temperature
- $5\sqrt{100}$  The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.

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## **Typical Characteristics**

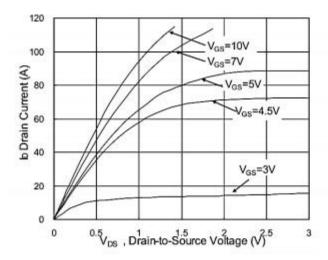


Fig.1 Typical Output Characteristics

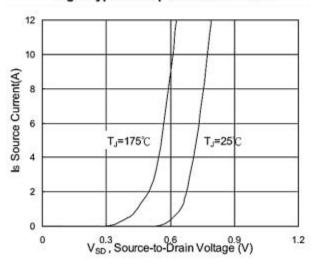


Fig.3 Forward Characteristics of Reverse

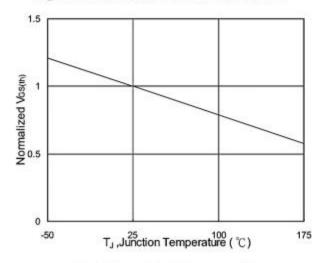


Fig.5 Normalized V<sub>GS(th)</sub> vs. T<sub>J</sub>

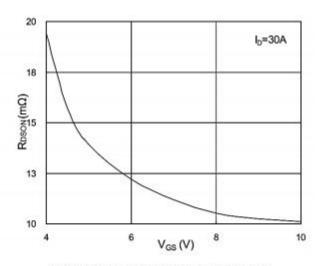


Fig.2 On-Resistance vs. G-S Voltage

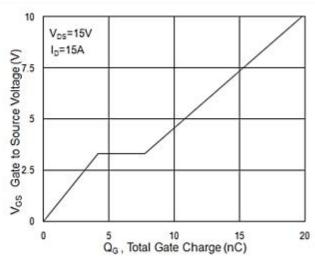


Fig.4 Gate-Charge Characteristics

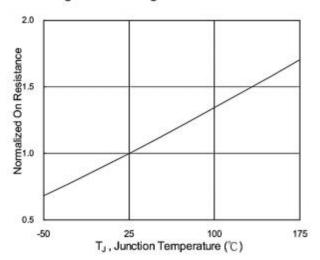
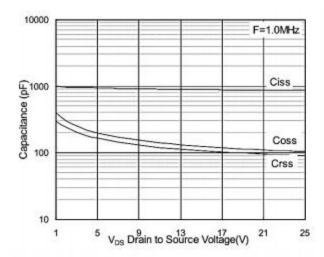


Fig.6 Normalized RDSON vs. TJ



## **Typical Characteristics**



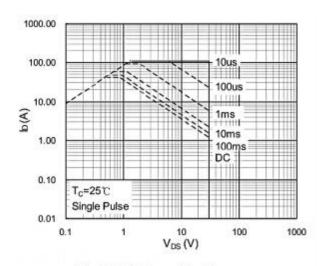


Fig.7 Capacitance

Fig.8 Safe Operating Area

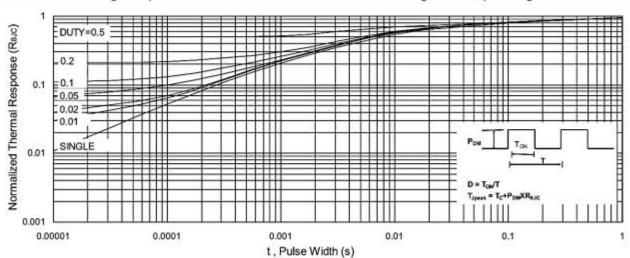


Fig.9 Normalized Maximum Transient Thermal Impedance

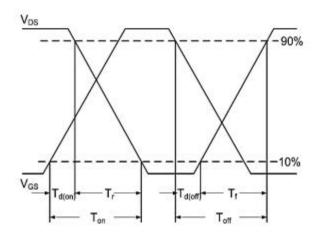


Fig.10 Switching Time Waveform

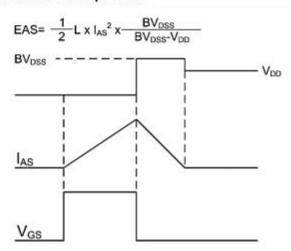
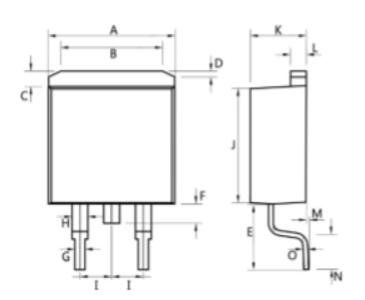


Fig.11 Unclamped Inductive Switching Waveform



## 30V N-Channel Enhancement Mode MOSFET

# Package Mechanical Data- TO-263-3L



Dim.	Min.	Max.		
Α	10.0	10. 5		
В	7.25	7.75		
С	1.3	1.5		
D	0.55	0.75		
E	5.0	6.0		
F	1.4	1.6		
G	0.75	0.95		
Н	1.15	1.35		
ı	Typ 2.54			
J	8.4	8.6		
K	4.4	4.6		
L	1.25	1.45		
M	0.02	0.1		
N	2.4	2.8		
0	0.35	0.45		
All Dimensions in millimeter				

**Package Marking and Ordering Information** 

Product ID	Pack Marking		D Pack Marking		Qty(PCS)	
TAPING	TO-263-3L		800			

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